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Substitute	Form	PT	<b>'O-1</b>	449
(Modified)				

.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 13298-013US1

Applicant

## **Information Disclosure Statement** by Applicant

(Use several sheets if necessary)

Takeshi Matsumoto et al. Filing Date

Group Art Unit

(37 CFR §1.98(b))

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
CIW	AA	US 2002/0086793	07/04/2002	Labarge et al.			
,	AB						
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		Foreign Patent Documents or Published Foreign Patent Applications								
	Examiner	Desig.	Document	Publication		try or			Transla	
	Initial	ID	Number	Date	Paten	Office	Class	Subclass	Yes	No
	CAL	AE	JP 60-125250	07/04/1985	Japan	A			Abstract	
	1	AF	JP 2-139040	05/29/1990	Japan	A			Partial translation	
		AG	JP 05-220403	08/31/1993	Japan	A			Abstract and partial translation thereof	
		АН	JP 07-008754	01/13/1995	Japan	D			Abstract and partial translation thereof	
		AI	JP 07-144134	06/06/1995	Japan	A			Abstract and partial translation thereof	
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(	Other D	ocuments (include Author, Title, Date, and Place of Publication)
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Examiner Signature	Date Considered 3/2-2-10 7
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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13298-013US1	Application No. 10/535,331
	closure Statement	Applicant Takeshi Matsumoto et a	al. 3 OCT 18 200
(Use several sh	eets if necessary)	Filing Date May 18, 2005	Group Art UNA

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial 、	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
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	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)						
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